

## Transaction Information

|                     |                 |
|---------------------|-----------------|
| Tool ID             | K259            |
| Tool Status         | Disconnected    |
| Location            | Burlington, USA |
| Wafer Size          | NA              |
| Fab Section         | Test            |
| Tool Available Date | 2022-11-03      |

## General Product Information

|                   |                        |
|-------------------|------------------------|
| Vendor Supplier   | KEITHLEY               |
| Model             | S425                   |
| Vintage           | 2001                   |
| Serial No         | QM02593                |
| Asset Description | Kerf Parametric Tester |
| Software Version  | NA                     |
| CIM               | NONE                   |
| Process           | Kerf Test              |

## Hardware Configuration (Fab)

| System Type       | Description | Quantity | Status |
|-------------------|-------------|----------|--------|
| Main System       | Test Can    | 1        | OK     |
| Handler System    | NONE        |          |        |
| Options System    |             |          |        |
| Factory Interface | NONE        |          |        |
| Others            |             |          |        |

## Hardware Configuration (Subfab / Auxilliary Units)

| Description | Quantity | Status |
|-------------|----------|--------|
|             |          |        |

## Missing/Faulty Parts / Accesories List

| Description | Quantity |
|-------------|----------|
| NONE        |          |

# Tool Pictures

General

test can



Manufacture Serial

Plate



## Additional Tool Data Files